

| Application/Control No. | Applicant(s)/Patent under Reexamination |
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| 09/734,176 | MIKAWA ET AL. |
| Examiner | Art Unit |
| Steven Loke | 2811 |

| | SEAR | CHED | |
|-------|----------------------|--------|----------|
| Class | Subclass | Date | Examiner |
| 257 | 532, 295 | 2/9/05 | Loke |
| | 295, 296, 767, | | |
| | 767, | | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | | |
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